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EAST Search History

L2	56	1 and model and (measure or measured or measuring)	USPAT	OR	ON	2006/05/18 13:37
L3	28	2 and curve	USPAT	OR	ON	2006/05/18 13:38
L4	16	3 and circuit	USPAT	OR	ON	2006/05/18 13:51
L5	111	(model with device) and (model with (uses or utilize or using) with circuit with elements)	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TD B	OR	ON	2006/05/18 14:00
L6	64	5 and (measure or measured or measuring)	US-PGPU B; USPAT; EPO; JPO; DERWEN T; IBM_TD B	OR	ON	2006/05/18 14:01
L7	36	5 and (measure or measured or measuring)	USPAT; EPO; JPO; DERWEN T; IBM_TD B	OR	ON	2006/05/18 14:00
L8	68	(model with device) and (model with (uses or utilize or using) with circuit with elements)	USPAT; EPO; JPO; DERWEN T; IBM_TD B	OR	ON	2006/05/18 14:00

EAST Search History

L9	36	8 and (measure or measured or measuring)	USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/05/18 14:33
L10	0	(use or using) adj3 (circuits or (circuit adj elements)) adj3 (model or modeling) adj3 device	USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	OFF	2006/05/18 14:35
L11	7	(circuits or (circuit adj elements)) adj3 (model or modeling) adj3 device	USPAT; EPO; JPO; DERWEN T; IBM_TDB	OR	OFF	2006/05/18 14:35